



THI safety system

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THI SAFETY SYSTEM

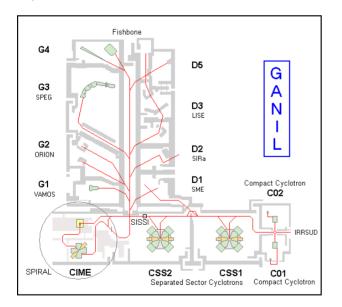
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Abstract

For several years, GANIL has been allowed to reach a maximum beam power of six kilowatts (400W in normal mode) thanks to the THI system (High Intensity Transport System). Three modes of running are necessary to accelerate a THI beam ("Injector" mode, "tuning" mode and "surveillance" mode). The "surveillance" mode requires a safety system to protect equipment against beam losses. Inside cyclotrons, diagnostics measure beam-loss currents at the injection and extraction devices. Along beam lines, diaphragms measure beam-loss currents at the input and output of dipoles. Current transformers are used for beam transmission measurements through beam lines and the cyclotrons. The safety system controls beam losses and quickly cuts the beam with a chopper if losses exceed thresholds. These thresholds can be seen and changed by software.

INTRODUCTION

The production of exotic ions at GANIL is performed by fragmentation of the projectile in the target of SISSI [5] or/and by the ISOL method with an acceleration of the exotic beams by the cyclotron CIME [3]. Layout of GANIL



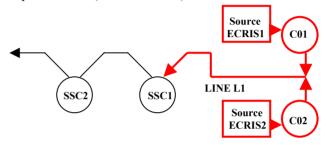
Both devices require high intensity primary beams. Primary beam intensity has been increased up to 15μ Ae (3kW) for ¹³C at 95Mev/A and 26 μ Ae (5kW) for ³⁶Ar at 95Mev/A. Therefore, uncooled or unshielded elements can melt very rapidly and must be protect by a safety system.

THI MODES

Three modes of running are necessary to tune a THI beam. C01 or C02 can be chosen to post accelerate the THI beam.

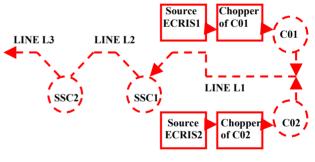
"Injector mode"

This mode permits us to accelerate the beam at the input of SSC1. (Pbeam < 400W)



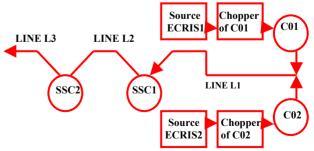
"Tuning mode"

This mode permits us to tune the beam through the accelerators. Beam chopping rates limit the beam power (Pbeam<400W)



"Surveillance mode"

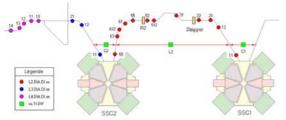
This mode permits us to tune the beam at a maximum power (Pbeam max = 6kW). Beam current average is increased progressively by changing beam-chopping rates. The safety system controls beam losses.



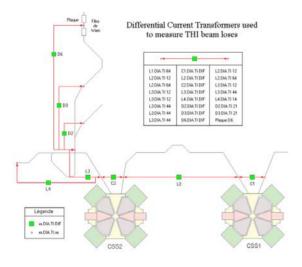
BEAM LOSSES DIAGNOSTICS

Inside cyclotrons, diagnostics measure beam-loss currents at the input of the injection an extraction. Along beam lines, diaphragms detect beam-loss currents at the input and output of dipoles.

Diaphragms used to detect THI beam loses



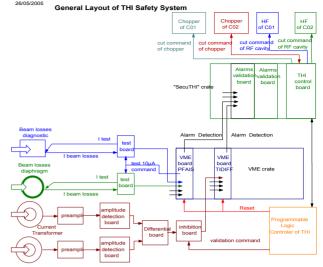
Current transformers (GANIL ACCT) are used to measure the beam transmission through beam lines and the cyclotrons. A change of the efficiency within the accelerators can be detected. The beam is modulated to measure beam currents with the ACCT. The maximum chopping rate is 91%.



SAFETY SYSTEM

Interceptive beam diagnostics are connected to test boards. Each board is able to inject a test signal (10 μ A) to the diagnostics and filter the signal from the device. Test signals can be sent by software. Each VME board (PFAIS) measures 4 diagnostic currents with logarithmic I/V converters, which generate a voltage proportional to the logarithm of the current. This voltage is digitised, compared to a threshold and numerically converted into a current.

The signals generated by the current transformers (ACCT) are sent to a differential board. An inhibition board validates the difference between 2 current transformers. Then a VME board digitises, compares to a threshold and numerically converts into a current.

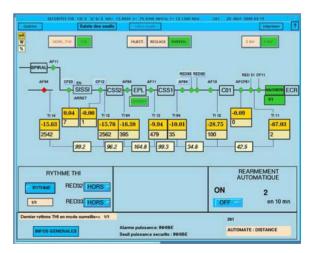


"Alarm detection" signals are generated by VME boards and sent to "alarm validation" boards. "THI control" board collects all alarm signals. A programmable logic controller indicates to the control board different configuration states. If "surveillance" mode is validated for example, when a VME board generates an alarm detection, the THI control board commands the chopper to cut the beam. If a problem is detected on the chopper, the acceleration voltage of the C0 injector is cut.

A reloading system gives us the possibility to restore the beam just after an overshoot. When 3 trigger actions arrive in under 10 seconds, the programmable logic controller passes from "surveillance " mode to "tuning" mode.

CONTROL

Software is used to control and tune the beam.



Users can choose various modes of running (normal mode or THI mode and injector, tuning, surveillance mode). Beam current (μ A), beam power (W) and efficiency (%) are displayed on the screen. Beam chopping rates can be changed (rythme) and pepper pots inserted in the lines (red32 and red33).

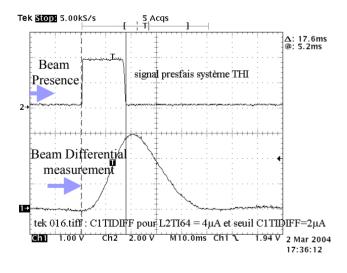
A second program enables us to control and change thresholds of each diagnostic device.

Quitter II	nit Seuils	Seuils en	Intensite	Fonction	sur seuils	Infos seuils	Test dep	assement	Imprimer	
	Pseul				Pseul		Pseul		Pseul	
Diagnostic C1.DIA.ELIHO	57 W	Diagnostic L2 DIA DI11 J	Pseull 5.7 W	Diagnostic C2.DIA.ELID	5.0 W	Diagnostic L3 DIA DI11J	23.8 W	Diagnostic L4.Dia.DI10.I	23.8 W	
C1.DIA ELIVE	5.7 W	L2 DIA DI12 J	5.7 W	C2 DIA ELIG	5.0 W	L3 DIA DI121	23.8 W	L4.DIA.DHUJ	23.8 W	
C1.DIA.EUVE	5.7 W	L2.DIA.DI21J	5.7 W	C2 DIA ELIB	5.0 W	L3.DIA.DI21	23.8 W	L4.D(A.D(11)	23.8 W	
C1.DIA.MI2.IVE	5.7 W	L2 DIA DI211	56.8 W	C2 DIA ELH	5.0 W	LADIA TOFI	46.4 W	L4.Dia.Dit2.	23.8 W	
C1.DIA.MD.I	5.7 W	L2 Dia Dig1 J	50.8 W	C2 DIA MI2 ID	5.0 W	L3 DIA TOT J	47.6 W	L4.Dia.Di14.	23.8 W	
C1.DIA.MIJ.I	5.7 W	L2 DIA DI521	15.0 W	C2 DIA MI2 IG	5.0 W	L3.DIA.001.1	47.6 W	L4.DIA.DIN4.I		
DIDIA EEU	5.7 W	L2 DIA DI5121	15.0 W	C2 DIA MI2 IB	5.0 W	Lapia Di411	23.8 W	C4.DGA.TIDIP.1	90.7 W	
C1.DIA.ME2.I	28.4 W	L2 DIA DISS J	5.0 W	C2 DIA MI2 IH	5.0 W	L3 DIA DI41	23.8 W			
C1.DIA.ME3.I	5.7 W	L2 DIA DIS1	5.0 W	C2 DIA MI2 IP	5.0 W	CODUCTION	23.8 W	AR DIA DID1	23.8 W	
C1.DIA MES.IHO		L2 DIA DI6221	50 W	C2 DIA MB ID	5.0 W			D2 DIA TIDE		
C1.DIA MES.IND	57 W	L2 DIA DI621	5.0 W	C2 DIA MB IG	5.0 W			D3.DIA.DI11.	23.8 W	
C1.DIA TIDIF.I	55.8 W	L2 DIA DI651	5.0 W	C2 DIA MB IB	5.0 W			D3.DIA.DI111	23.8 W	
CTDACHOFT	30.8 W	L2 DIA TOFI	50.1 W	C2 DIA MB ID	5.0 W			D3.DIA.DI21	23.8 W	
		CEDUCTION J	30.1 W	C2 DIA MB IP	5.0 W			D3.DIA.TDIF		
				C2 DIA MI3 IPB	50W			DS.DIA.TIDIF		
				C2 DIA M3 IPB	5.0 W			D6.DIA.TIDIPJ	47.6 W	
				C2 DIA MILIG	5.0 W					
				C2 DIA MILIB	5.0 W					
				C2 DIA MAJH	5.0 W					
				C2 DIA MAJP	5.0 W					
				C2 DIA MELL	5.0 W					
				C2 DIA EE IPLA	23.8 W					
				C2 DIA EE IFIL	118.9 W					
				C2.DIA.EE.IVE	23.8 W					
				C2 DIA ME2 I	23.8 W					
				C2 DIA ME3.1	47.5 W					
				C2 DIA MES INO						
					23.8 W					
				C2 DIA TIDIF I	23.8 W					
				C2.D04.TIDIP.I	135.4 W					
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Current or power thresholds can be selected. When a new beam is tuned, we initialise all thresholds in power with beam characteristics. Each value can be displayed and modified. A test command permits sending a test current to each beam-loss diagnostic device and to verify the detection.

RESPONSE TIME

To measure the response time, the beam is tuned to lose $4\mu Ae$ in SSC1. We cut the beam by the chopper and we set the threshold to $2\mu Ae$. The beam is then sent through the cyclotron, and the safety system detects the loss and stops the beam.



The response time for a beam current of $4\mu A$ and a threshold of $2\mu A$ is around 18 ms. It depends of the ratio between threshold and loss current.

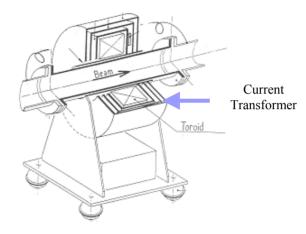
PHOTOS OF DIAGNOSTICS





Beam-loss diagnostic inside cyclotron

Beam-loss diaphragm



CONCLUSIONS

The THI Safety System was started in 1995, validated in 1998 and completed in 2001, to give the possibility to send a THI beam into the experimental rooms. The system correctly protects equipment against the beam power loss.

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